

Notice of References Cited

Application/Control No.

10/056,716

Applicant(s)/Patent Under
Reexamination
CHANDRASEKARAN ET AL.

Examiner

Susan Y Chen

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,454,108	09-1995	Devarakonda et al.	710/200
	B	US-5,285,528	02-1994	Hart, Caswall A.	710/200
	C	US-6,353,836	03-2002	Bamford et al.	707/203
	D	US-6,668,295	12-2003	Chan, Wilson Wai Shun	710/200
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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